

MOS FIELD EFFECT TRANSISTOR 2SK3659

SWITCHING N-CHANNEL POWER MOS FET

DESCRIPTION

The 2SK3659 is N-channel MOS FET device that features a low on-state resistance and excellent switching characteristics, designed for low voltage high current applications such as DC/DC converter with synchronous rectifier.

ORDERING INFORMATION

| PART NUMBER | PACKAGE |
|-------------|-----------------|
| 2SK3659 | Isolated TO-220 |

FEATURES

- •4.5V drive available.
- •Low on-state resistance,

 $R_{DS(on)1} = 5.7 \text{ m}\Omega \text{ MAX.} \text{ (Vgs} = 10 \text{ V, ID} = 40 \text{ A)}$

·Low gate charge,

 $Q_G = 32 \text{ nC TYP.}$ (VDD = 16 V, VGS = 10 V, ID = 65 A)

- •Built-in gate protection diode.
- Avalanche capability ratings.
- •Isolated TO-220 package.

ABSOLUTE MAXIMUM RATING (TA = 25°C)

| Drain to source voltage (Vgs = 0 V) | VDSS | 20 | V |
|---|------------------|-------------|----|
| Gate to source voltage (V _{DS} = 0 V) | Vgss | ±20 | V |
| Drain current (DC) (Tc = 25°C) | ID(DC) | ±65 | Α |
| Drain current (pulse) Note1 | ID(pulse) | ±260 | Α |
| Total power dissipation (T _A = 25°C) | P _{T1} | 2.0 | W |
| Total power dissipation (Tc = 25°C) | P _{T2} | 25 | W |
| Channel temperature | Tch | 150 | °C |
| Storage temperature | T _{stg} | -55 to +150 | °C |
| Single Avalanche Current Note2 | IAS | 35 | Α |
| Single Avalanche Energy Note2 | Eas | 122 | mJ |

Note 1. PW \leq 10 μ s, Duty Cycle \leq 1%

2. Starting T_{ch} = 25°C, V_{DD} = 10 V, R_{G} = 25 $\Omega,\,V_{GS}$ = 20 \rightarrow 0 V

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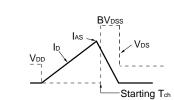


ELECTRICAL CHARACTERISTICS (TA = 25°C)

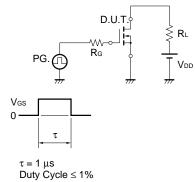
| Characteristics | Symbol | Test Conditions | MIN. | TYP. | MAX. | Unit |
|-------------------------------------|----------------------|---|------|------|------|------|
| Zero Gate Voltage Drain Current | IDSS | V _{DS} = 20 V, V _{GS} = 0 V | | | 10 | μΑ |
| Gate Leakage Current | Igss | Vgs = ±20 V, Vps = 0 V | | | ±10 | μΑ |
| Gate Cut-off Voltage | V _{GS(off)} | V _{DS} = 10 V, I _D = 1 mA | 1.5 | | 2.5 | ٧ |
| Forward Transfer Admittance | yfs | V _{DS} = 10 V, I _D = 40 A | 15 | | | S |
| Drain to Source On-state Resistance | RDS(on)1 | Vgs = 10 V, ID = 40 A | | 4.6 | 5.7 | mΩ |
| | RDS(on)2 | Vgs = 4.5 V, ID = 40 A | | 7.1 | 9.9 | mΩ |
| Input Capacitance | Ciss | Vps = 10 V | | 1700 | | pF |
| Output Capacitance | Coss | Vgs = 0 V | | 700 | | pF |
| Reverse Transfer Capacitance | Crss | f = 1 MHz | | 250 | | pF |
| Turn-on Delay Time | td(on) | V _{DD} = 10 V, I _D = 40 A | | 16 | | ns |
| Rise Time | tr | Vgs = 10 V | | 14 | | ns |
| Turn-off Delay Time | td(off) | $R_G = 10 \Omega$ | | 50 | | ns |
| Fall Time | tr | | | 12 | | ns |
| Total Gate Charge | Q _G | VDD = 16 V | | 32 | | nC |
| Gate to Source Charge | Qgs | V _G S = 10 V | | 6.0 | | nC |
| Gate to Drain Charge | Q _{GD} | ID = 65 A | | 8.3 | | nC |
| Body Diode Forward Voltage | V _{F(S-D)} | IF = 65 A, VGS = 0 V | | 1.0 | | V |
| Reverse Recovery Time | trr | IF = 65 A, VGS = 0 V | | 45 | | ns |
| Reverse Recovery Charge | Qrr | di/dt = 100 A/μs | | 34 | | nC |

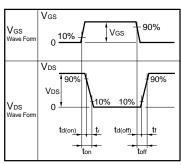
TEST CIRCUIT 1 AVALANCHE CAPABILITY

$\begin{array}{c} \text{D.U.T.} \\ \text{Rg} = 25 \, \Omega \\ \text{Ves} = 20 \rightarrow 0 \, \text{V} \end{array} \begin{array}{c} \text{PG.} \\ \text{PS.} \\ \text{W.-o.} \end{array} \begin{array}{c} \text{D.U.T.} \\ \text{V.DD.} \\ \text{V.DD.} \end{array}$

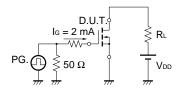


TEST CIRCUIT 2 SWITCHING TIME



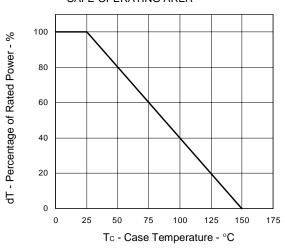


TEST CIRCUIT 3 GATE CHARGE

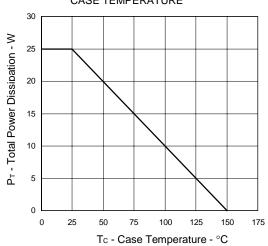


TYPICAL CHARACTERISTICS (TA = 25°C)

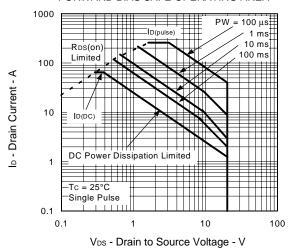
DERATING FACTOR OF FORWARD BIAS SAFE OPERATING AREA



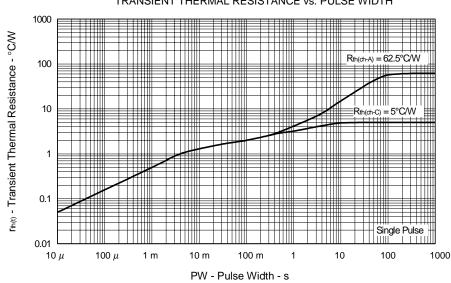
TOTAL POWER DISSIPATION vs. CASE TEMPERATURE



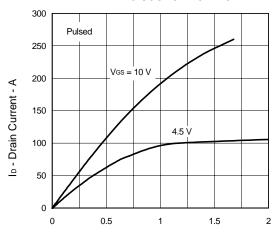
FORWARD BIAS SAFE OPERATING AREA



TRANSIENT THERMAL RESISTANCE vs. PULSE WIDTH

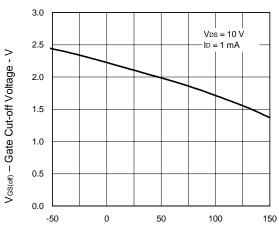


DRAIN CURRENT vs. DRAIN TO SOURCE VOLTAGE



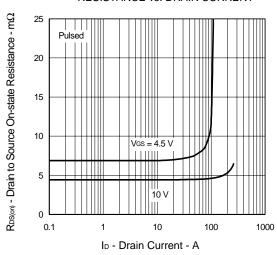
V_{DS} - Drain to Source Voltage - V

GATE CUT-OFF VOLTAGE vs. CHANNEL TEMPERATURE

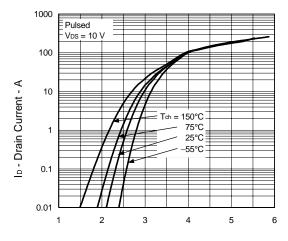


Tch - Channel Temperature - °C

DRAIN TO SOURCE ON-STATE RESISTANCE vs. DRAIN CURRENT

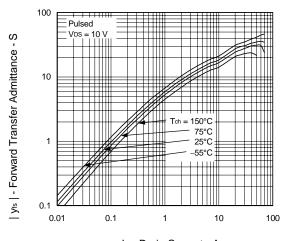


FORWARD TRANSFER CHARACTERISTICS



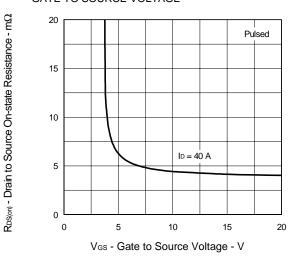
V_{GS} - Gate to Source Voltage - V

FORWARD TRANSFER ADMITTANCE vs. DRAIN CURRENT

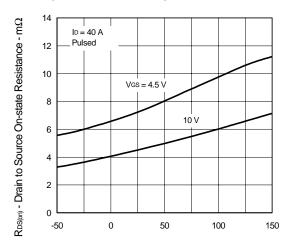


ID - Drain Current - A

DRAIN TO SOURCE ON-STATE RESISTANCE vs. GATE TO SOURCE VOLTAGE

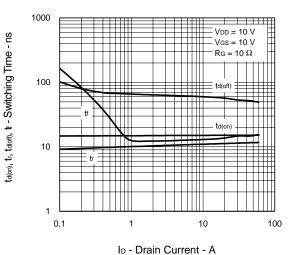


DRAIN TO SOURCE ON-STATE RESISTANCE vs. CHANNEL TEMPERATURE

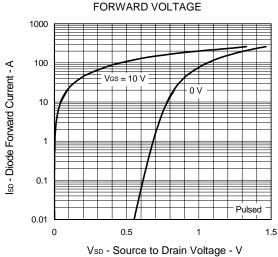


Tch - Channel Temperature - °C

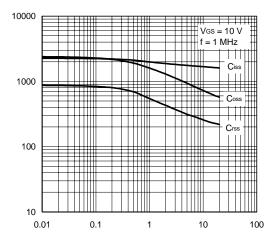
SWITCHING CHARACTERISTICS



SOURCE TO DRAIN DIODE

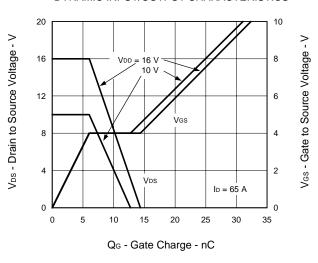


CAPACITANCE vs.
DRAIN TO SOURCE VOLTAGE

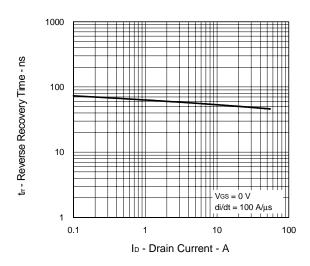


V_{DS} - Drain to Source Voltage - V

DYNAMIC INPUT/OUTPUT CHARACTERISTICS

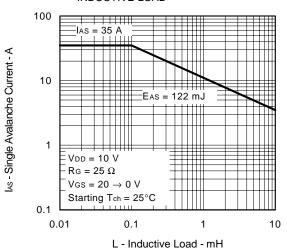


REVERSE RECOVERY TIME vs. DRAIN CURRENT

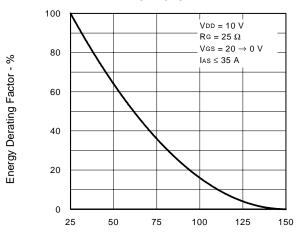


Ciss, Coss, Crss - Capacitance - pF

SINGLE AVALANCHE CURRENT vs. INDUCTIVE LOAD



SINGLE AVALANCHE ENERGY DERATING FACTOR

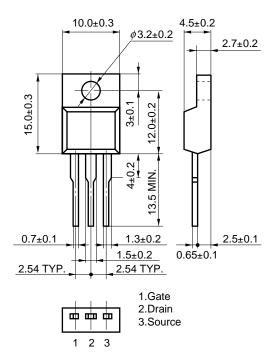


Starting Tch - Starting Channel Temperature - °C

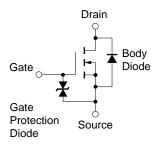


PACKAGE DRAWING (Unit: mm)

Isolated TO-220 (MP-45F)



EQUIVALENT CIRCUIT



Remark The diode connected between the gate and source of the transistor serves as a protector against ESD. When this device actually used, an additional protection circuit is externally required if a voltage exceeding the rated voltage may be applied to this device.

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